

# 47 CFR PART 15B

# **TEST REPORT**

of

HC-CG200 Model Name: HC-CG200 Brand Name: Haier Report No.: SZ08120043E01 FCC ID: SG70902HC-CG200

prepared for

Qingdao Haier Telecom Co., Ltd. No.1,Haier Road,Hi-tech Zone,Qingdao,266101,P.R.China



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## 1. Test Result Certification

Equipment under Test: HC-CG200

Brand Name:	Haier
Model Name:	HC-CG200
FCC ID:	SG70902HC-CG200
Applicant:	Qingdao Haier Telecom Co., Ltd.
	No.1, Haier Road, Hi-tech Zone, Qingdao, 266101, P.R. China
Manufacturer:	Qingdao Haier Telecom Co., Ltd.
	No.1, Haier Road, Hi-tech Zone, Qingdao, 266101, P.R. China
Emission Designator:	1M25F9W
Test Standards:	47 CFR Part 2
	47 CFR Part 15 Subpart B
Test Date(s):	February 17, 2009- February 27, 2009

Test Result: PASS

#### \* We Hereby Certify That:

The equipment under test was tested by Shenzhen Morlab Communications Technology Co., Ltd. The test data, data evaluation, test procedures and equipment configurations shown in this report were made in accordance with the requirement of related FCC rules.

The test results of this report only apply for the tested sample equipment identified above. The test report shall be invalid without all the signatures of the test engineer, the reviewer and the approver.

Tested by:	1:.7;	Dated:	2009. 3. 4.
Reviewed by:	mangalo	DRL Dated	
Approved by:	wei ranquan	rtification	2009.03.04
	Shu Luan		

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# 2. General Information

# 2.1 Equipment under Test (EUT) Description

Sample Description:	HC-CG200	
Model Name:	HC-CG200	
Serial No	(n.a, marked #1	by test site)
Hardware Version:	H01	
Software Version:	S001	
Modulation:	CDMA 1X	
Frequency:	Tx: 824.7 - 848.	.31MHz; Rx: 869.7 - 893.31MHz
Power Supply::	Battery	
	Brand name:	Haier
	Model Name:	H15159
	Capacitance:	1200mAh
	Rated voltage:	3.7V
	Charge limited:	4.2V
	Manufacturer:	SHENZHEN XWODA ELECTRONIC CO.LTD
		Building C, Tongfukang Industrial Zone
		ShiyanTown, Baoan, District, ShenZhen, China
Accessory Equipment:	AC Adapter (Ch	arger for Battery)
		Brand Name: Haier
	Model Name:	H24142
	Rated Input:	~ 100V-240V, 0.2A, 50/60Hz
	Rated Output:	= 5.0V, 0.55A
	Manufacturer:	ZHONGWEI INDUSTRIAL PARK
		Fushan Industial Area, Jiangshan Town Laixi
		City, Qingdao, Shandong, China
	Wire Length:	100cm

#### NOTE:

- 1. The EUT is a model of CDMA 1X mobile station operating in Cellular band.
- 2. The normal configuration for the EUT is the Mobile Phone (MS) associated with ancillary equipments e.g. the Battery and/or the AC Adapter (Charger).
- 3. For detailed features about the EUT, please see user manual supplied by the applicant.



## 2.2 Test Standards and Results

The objective of the report is to perform tests according to 47 CFR Part 2, Part 15 Part 22 for FCC ID Certification:

No.	Identity	Document Title
1	47 CFR Part 2	Frequency Allocations and Radio Treaty Matters; General Rules and
	(10-1-05 Edition)	Regulations
2	47 CFR Part 15	Radio Frequency Devices
	(10-1-05 Edition)	

Test detailed items and the results are as below:

No.	Rules	Test Type	Result	Date of Test
FCC	Part 15 Red	quirement		
1	§15.107	Conducted Emissions	PASS	2009-02-18
2	§15.109	Radiated Emissions	PASS	2009-02-18

#### NOTE:

The tests were performed according to the method of measurements prescribed in ANSI C63.4 2003.



## Facilities and Accreditations

#### 2.2.1 Facilities

Shenzhen Electronic Product Quality Testing Center Morlab Laboratory is a testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is CNAS L1659.

All measurement facilities used to collect the measurement data are located at Electronic Testing Building, Shahe Road, Xili, Nanshan District, Shenzhen, P. R. China. The site was constructed in conformance with the requirements of ANSI C63.7, ANSI C63.4 and CISPR Publication 22, the FCC registration number is 741109.

No.	Description	Specification	
1	System Simulator	Manufacturer:	Rohde&Schwarz
		Model No.:	CMU200
		Serial No.:	100448
2	System Simulator	Manufacturer:	Agilent
		Model No.:	E5515C
		Serial No.:	GB43130131
3	Spectrum Analyzer	Manufacturer:	Agilent
		Model No.:	E7405A
		Serial No.:	US44210471
4	Telecommunication	Manufacturer:	European Antennas
	Antenna	Model No.:	PSA-45010R/356
		Serial No.:	403688-001
5	Trilogy Antenna	Manufacturer:	Schwarzbeck
		Model No.:	VULB 9163
		Serial No.:	9163-274
6	Horn Antenna	Manufacturer:	Schwarzbeck
		Model No.:	BBHA 9120C
		Serial No.:	9120C-384
7	Power Splitter	Manufacturer:	WEINSCHEL
		Model No.:	1506A
		Serial No.:	NW521
8	Anechoic Chamber	Manufacturer:	Albatross Projects GmbH
9	DC Power Supply	Manufacturer:	Good Will Instrument Co., Ltd.
10	Temperature Chamber	Manufacturer:	Chongqing YinHe Experimental Equip. Co., Ltd.

#### 2.2.2 Test Equipments



## NOTE:

1. Equipments listed above have been calibrated and are in the period of validation.

## 2.2.3 Test Environment Conditions

During the measurement, the environmental conditions were within the listed ranges:

Temperature:	20 - 25°C
Relative Humidity:	40 - 60%
Atmospheric Pressure:	86-106kPa



# **3. 47 CFR Part 15B Requirements**

## 3.1 General Information

#### 3.1.1 Test Mode

The EUT configuration of the emission tests was MS + Battery + Charger

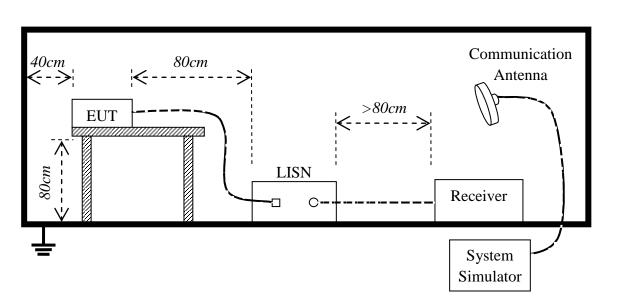
Before the measurement, the lithium battery was completely discharge.

During the measurement, the lithium battery was installed into the MS, and the charger was connected to the MS. A communication link was established between the MS and a System Simulator (SS).



## 3.1.2 Test Setup

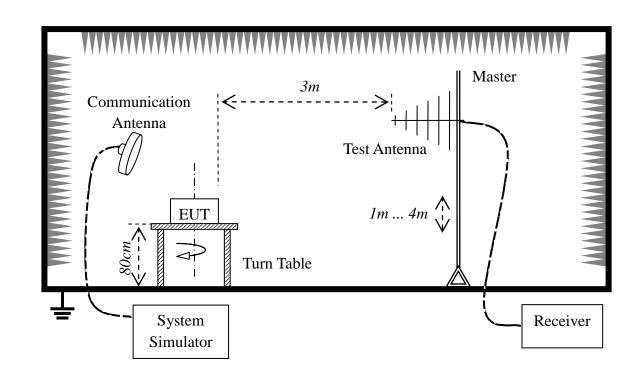
### 3.1.2.1 Conducted Emission Test



- 1. The test is performed in a Shield Room; the factors of the test system are calibrated to correct the reading.
- 2. The EUT is placed on a 0.8 meters high insulating table and keeps 0.4 meters away from the conducting wall of the Shield Room.
- 3. The EUT is connected to the power mains through a Line Impedance Stabilization Network (LISN). The LISN provides  $50\Omega/50\mu$ H of coupling impedance for the measuring instrument.



#### 3.1.2.2 Radiated Emission Test



- 1. The test is performed in a Semi-anechoic Chamber; the factors of the test system are calibrated to correct the reading.
- 2. The EUT is placed on a 0.8 meters high insulating table and keeps 3 meters away from the trilogy Test Antenna, which is mounted on the top of a variable-height antenna Master tower.

NOTE:

1. The test method is the substitution method according to TIA-603-C.



## **3.2** Conducted Emission

#### 3.2.1 Requirement

According to FCC 15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a  $50\mu$ H/ $50\Omega$  line impedance stabilization network (LISN).

Eroquanau ranga (MUz)	Conducted Limit (dBµV)		
Frequency range (MHz)	Quasi-peak	Average	
0.15 - 0.50	66 to 56	56 to 46	
0.50 - 5	56	46	
5 - 30	60	50	

NOTE:

- 1. The limit subjects to the Class B digital device.
- 2. The lower limit shall apply at the band edges.
- 3. The limit decreases linearly with the logarithm of the frequency in the range 0.15MHz to 0.50MHz.

#### 3.2.2 Test Procedure

- 1. Perform test setup as described in section 3.1.2.1.
- 2. Each test mode in section 3.1.1 should be applied. At each test mode, the frequency range from 150 kHz to 30MHz is searched using the CISPR Quasi-Peak and/or the Average detector of the Receiver. If the emission levels measured with Quasi-Peak detector are lower than the Average Limit, it's not necessary to measure with Average detector.
- 3. The emission levels at both L phase and N phase should be tested.
- 4. Record the test result plot and distinct points.
- 5. In the test report show the worst test data.



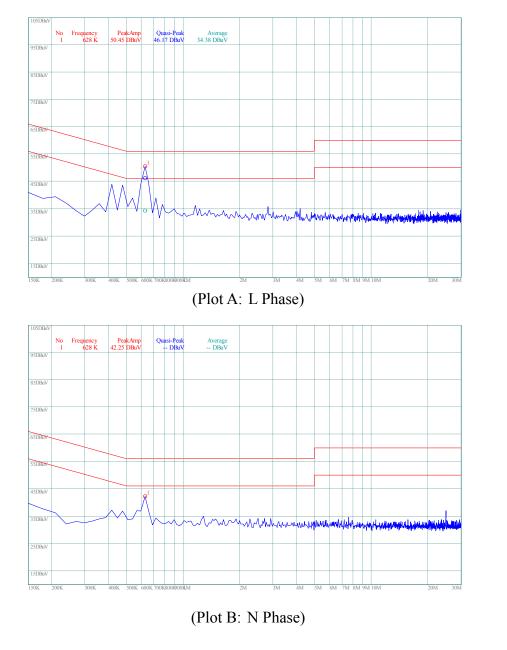
## 3.2.3 Test Result

A. Test Verdict Recorded for Suspicious Points:

No.	@Frequency	Measured Emission Level (dBµV)				Limit (	dBµV)	Verdict			
INO.	(MHz)	РК	QP	AV	Phase	QP	AV	verdict			
1	0.628	50.45	46.17	34.38	L	56.0	46.0	PASS			
2	0.628	42.25			Ν	56.0	46.0	PASS			

Note: "--" in the table above means that the emissions are too small to be measured and are at least 20 dB below the limit.

#### B. Test Plot





## 3.3 Radiated Emission

#### 3.3.1 Requirement

According to FCC §15.109, the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

	Field Strength		
Frequency range (MHz)	μV/m	dBµV/m	
30 - 88	100	40	
88 - 216	150	43.5	
216 - 960	200	46	
Above 960	500	54	

NOTE:

- 1. Field Strength  $(dB\mu V/m) = 20*\log[Field Strength (\mu V/m)].$
- 2. In the emission tables above, the tighter limit applies at the band edges.

#### 3.3.2 Test Procedure

- 1. Perform test setup as described in section 3.1.2.2.
- 2. Each test mode in section 3.1.1 should be applied. At each test mode, the Turn Table turns from 0 degrees to 360 degrees to find the maximum reading; for the suspected points, the Test Antenna varies from 1 meter to 4 meters to determine the maximum value of the field strength.
- 3. The Receiver is set to Peak Detector function and specified bandwidth with maximum hold mode. If the emission level of the EUT in peak mode is 6dB lower than the limit specified, then testing could be stopped and the peak values would be reported; otherwise the emission less than 6dB margins would be retested one by one using the quasi-peak method.
- 4. The emission levels at both horizontal and vertical polarizations should be tested.
- 5. Record the test result plot and distinct points.
- 6. In the test report show the worst test data.

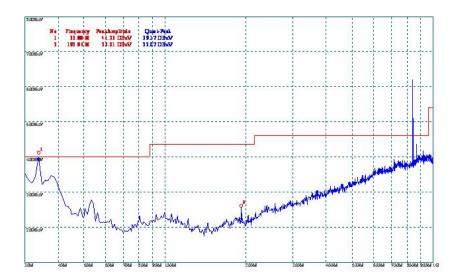


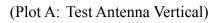
## 3.3.3 Test Result

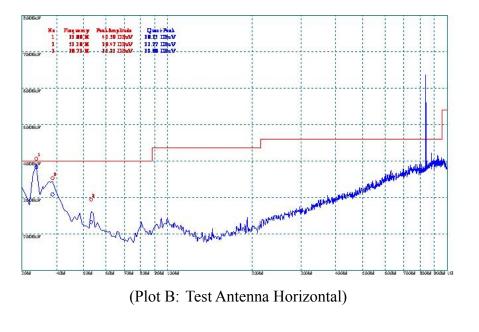
A. Test Verdict Recorded for Suspicious Points:

No.	Frequency	E	Emission Level	$(dB\mu V/m)$	Quasi-Peak	Result
INO.	(MHz)	Peak	Quasi-Peak	Antenna Polarization	Limit (dBµV/m)	Result
1	33.88	41.23	39.17	Vertical	40.0	PASS
2	192.96	26.01	22.07	Vertical	43.5	PASS
3	33.88	40.59	38.35	Horizontal	40.0	PASS
4	38.73	35.25	30.88	Horizontal	40.0	PASS

B. Test Plot









Report No.: SZ08120043E01

#### \*\*\*\*\* END OF REPORT\*\*\*\*\*